



<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10530494	SUCH ET AL.
	Examiner Kowalewski, Filip A	Art Unit 3736

Notes	Date	Examiner
EAST Search	10/18/2006 - 10/25/2006-	FAK
IDS Search	10/25/2006	FAK
PLUS Search	10/25/2006	FAK
Inventor Search	10/25/2006	FAK
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Class	SubClass	Date	Examiner
600	300	10/25/2006	FAK
128	903-905; 920	10/25/2006	FAK

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